# (1005 (0402)×2 size, chip capacitor networks)

#### Features

Two multi-layer ceramic capacitors are integrated on a single chip providing reduced cost and mounting space.

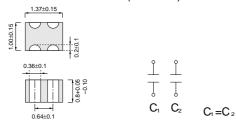
#### Quick Reference

The design and specifications are subject to change without prior notice. Please check the most recent technical specifications prior to placing orders or using the product. For more detail information regarding packaging style code, please check product designation.

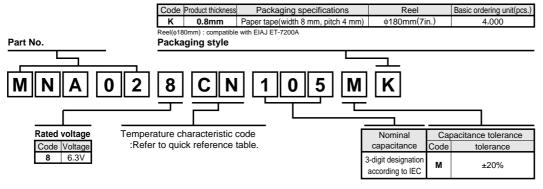
## High dielectric constant

Part No.	Size code	Temperature characteristics		Operating temp. range (°C)	Rated voltage (V)	Capacitance(pF)	Capacitance tolerance	Thickness	
		code		( 0)	(v)		tolerance	(mm)	
MNA02	1005x2 (0402x2)	CN	±15% (X5R)	-25 to +85	6.3	1,000,000	M(±20%)	0.8+0.05 -0.10	

## ●External dimensions (Unit : mm)



## Product designation





## Performance and test method

No.	Items	Performance		Test Method (As per JIS C 5101-1, JIS C 5101-10)			
1	Appearance and dimensions	No marked defects shall be for appearance. Dimensions shall be as speclause 4.		As per 4.4 of JIS C 5101-1. As per 4.5 of JIS C 5101-10 Using a Magnifier.			
2	Withstanding voltage	No dielectrical breakdown of damage shall be allowed.	or other	As per 4.6 of JIS C 5101-1. As per 4.6.4 of JIS C 5101-10 Voltage shall be applied as per Table1.  Table 1  Characteristic Voltage  CN 250% Rated voltage  Voltage shall be applied for 1 to 5s with 50mA charging and discharging current.			
3	Insulation resistance	Not less than 100MΩ• μF		As per 4.5 of JIS C 5101-1. As per 4.6.3 of JIS C 5101-10 Measurements shall be made after 60+/–5s period of the rated voltage applied.			
4	Capacitance	within +/-20%		As per 4.7 of JIS C 5101-1. As per 4.6.1 of JIS C 5101-10 Measurements shall be made under the conditions specified in Table 2.  Table 2  Characteristic Frequency • Voltage  CN 1+/-0.1kHz 1+/-0.1Vrms.			
5	Dielectric loss tangent	tan δ≤ 10.0%		As per 4.8 of JIS C 5101-1. As per 4.6.2 of JIS C 5101-10 Measurements shall be made under the conditions specified in Table 2.			
6	Temperature characteristic	voltage         I           0Vdc         Within +/-15% +           0Vdc         Within +/-10% +           3.15         Within	pperature range 55°C~ 85°C 25°C~ 85°C 25°C~ 85°C	As per 4.24 of JIS C 5101-1. As per 4.7 of JIS C 5101-10 If required, measurements shall be made at a given temperature. Measurements shall be made under the conditions specified in Table 2.  Table 2  Characteristic Frequency Voltage  CN 1+/-0.1kHz 1+/-0.1Vrms.			
7	Solderability	More than 3/4 of each end termination shall be covere new solder.	d with	As per 4.15.2 of JIS C 5101-1. As per 4.11 of JIS C 5101-10 The solder specified in JIS Z 3282 H63A shall be used. And the flux containing 25% rosin and ethanol solution shall be used. The specimens shall be immersed into the solder at 235+/-5°C for 2+/-0.5s So that both end terminations are completely under solder.			



No.	Ite	ms	Performance	Test Method (As per JIS C 5101-1, JIS C 5101-10)		
8	Resistance to soldering	Appearance	Without mechanical damage.	As per 4.14 of JIS C 5101-1.  As per 4.10 of JIS C 5101-10		
	heat	Change rate from initial value	Within +/-7.5%	The solder specified in JIS Z 3282. H63A shall be used. The specimens shall be immersed into the		
		Dielectric loss tangent	Within specified initial value.	solder at 260+/–5°C for 5+/–0.5s so that both end terminations are completely under the solder.  Pre-heating at 150+/–10°C for 1 to 2min		
		Insulation resistance	Within specified initial value.	Initial measurements prior to test shall be performed after the thermal		
		Withstanding voltage	No defects shall be allowed.	Pre-conditioning specified in Remarks (1). Final measurements shall be made after the specimens have been left at room temperature as per Table3.  Table 3  Characteristic Time CN 48+/-4 h		
9	End termination adherence		Without peeling or sign of peeling shall be allowed on the end terminations.	As per 4.13 of JIS C 5101-1. As per 4.8 of JIS C 5101-10 A 2N weight for 10+/-1s shall be applied to the soldered specimens as shown by the arrow mark in the below sketch.		
10	Bending Appearance strength		Without mechanical damage.	As per 4.35 of JIS C 5101-1. As per 4.9 of JIS C 5101-10 Glass epoxy board with soldered specimens shall be bent till 1mm by 1.0mm/s.		
11	Vibration	Appearance	Without mechanical damage.	As per 4.17 of JIS C 5101-1.  The specimens shall be soldered on the		
		Change rate from initial value	Within +/-7.5%	specified test jig. Initial measurements shall be made after the thermal pre-conditioning specified in		
		Dielectric loss tangent	Within specified initial value.	Remarks(1). Final measurements shall be made after the specimens have been left at room temperature as per Table3. [Condition] Directions: 2h each X, Y and Z directions Total: 6h Frequency range: 10 to 55 to 10Hz(1min) Applitude: 1.5mm (shall not exceed acceleration196m/s²)  Table 3  Characteristic Time CN 48+/-4 h		

No.	Iter	ms	Performance	Test Method (As per JIS C 5101-1, JIS C 5101-10)			
12	Temperature cycling	Appearance	Without mechanical damage.	As per 4.16 of JIS C 5101-1 As per 4.12 of JIS C 5101-10			
		Change rate from initial value	Within +/-15.0%	The specimens shall be soldered on the test jig shown in Remarks. Temperature cycle: 100cycles Initial			
		Dielectric loss tangent	Within specified initial value.	measurements prior to test shall be performed after the thermal per-conditioning specified in Remarks (1).  Final measurements shall be made after the			
		Insulation resistance	Within specified initial value.	specimens have been left at room temperature as per Table3.			
		Withstanding	No defects shall be allowed.	Test condition			
		voltage		Step Temp. (°C) Time (min)  1 Min operating temp. 30+/–3			
				2 Room temp. ≤3			
				3 Max operating temp. 30+/-3			
				4 Room temp. ≤3			
				Table 3			
				Characteristic Time			
				CN 48+/–4 h			
13	Humidity (Steady)	Appearance	Without mechanical damage.	As per 4.22 of JIS C 5101-1 As per JIS C 5101-10			
	, ,,	Change rate from initial value	Within +/-25%	Test temperature : 60+/-2°C Relative humidity : 90 to 95% Test time : 500 +24/-0 h			
		Dielectric tangent	Less than 200% of initial spec.	Initial measurements prior to test shall be made after the voltage pre-conditioning specified in Remarks (2).			
		Insulation resistance	Not less than $10M\Omega$ .	Final measurements have been left at room temperature as per Table3.  Table 3			
				Characteristic Time			
				CN 48+/–4 h			
14	Humidity life test	Appearance	Without mechanical damage.	As per 4.22 of JIS C 5101-1 As per 4.14 of JIS C 5101-10			
		Change rate from initial value	Within +/-25.0%	Test temperature : 60+/–2°C Relative humidity : 90 to 95% Voltage : Rated voltage			
		Dielectric loss tangent	Less than 200% of initial spec.	Test time: 500 +24/–0 h Initial measurements prior to test shall be made after the voltage pre-conditioning specified in			
		Insulation resistance Not less than $5M\Omega$ .		Remarks (2). Final measurements shall be made after the specimens have been left at room temperature as per Table3.  Table 3			
				Characteristic Time			
				CN 48+/-4 h			

No.	Items		Performance	Test Method (As per JIS C 5101-1, JIS C 5101-10)				
15	Heat life test	Appearance	Without mechanical damage.		As per 4.23 of JIS C 5101-1. As per 4.15 of JIS C 5101-10			
	1001	Change rate from initial value	Within +/-25.0%		Test Voltage Test			
		Dielectric loss tangent Insulation resistance	Less than 200% of initial spec. Not less than 10M $\Omega$ .		temperature		time (h)	
					85°C	Rated voltage	1000 +48/–0	
				sp Fir	Initial measurements prior to test shall be made after the voltage pre-conditioning specified in Remarks (2). Final measurements shall be made after the specimens have been left at room temperature			
					Table 3			
					Characteris		Time	
					CN	4	18+/-4 h	

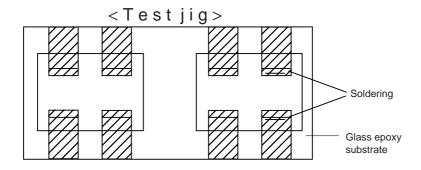
## [Remarks]

## Pre-conditioning

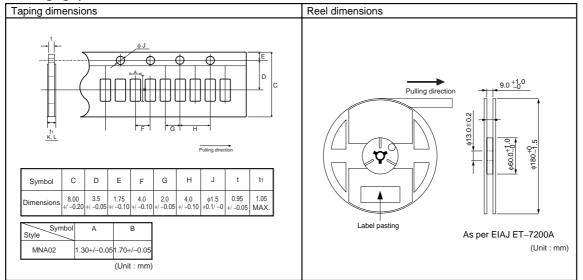
If specified in test method of as per 3(Performance and test method), capacitors of CNcharacteristics shall be pre-conditionded as follows.

- (1) Thermal pre-conditioning
  - Prior to initial measurements, specimens shall be conditioned at a temperature of 150  $\,$  0/ $-10^{\circ}$ C for a period of 1hr., and shall be allowed to stabilize at room temperature for 48+/-4h
- (2) Voltage pre-conditioning

Prior to initial measurements, voltage specified as a test condition shall be applied to specimens for a period of 1hr., and the specimens shall be allowed to stabilize at room temperature for 48+/-4h



## Packaging specifications



## •Electrical characteristics curves

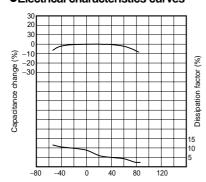


Fig.1 Temperature (°C)

## **Appendix**

#### **Notes**

- No technical content pages of this document may be reproduced in any form or transmitted by any
  means without prior permission of ROHM CO.,LTD.
- The contents described herein are subject to change without notice. The specifications for the
  product described in this document are for reference only. Upon actual use, therefore, please request
  that specifications to be separately delivered.
- Application circuit diagrams and circuit constants contained herein are shown as examples of standard use and operation. Please pay careful attention to the peripheral conditions when designing circuits and deciding upon circuit constants in the set.
- Any data, including, but not limited to application circuit diagrams information, described herein are intended only as illustrations of such devices and not as the specifications for such devices. ROHM CO.,LTD. disclaims any warranty that any use of such devices shall be free from infringement of any third party's intellectual property rights or other proprietary rights, and further, assumes no liability of whatsoever nature in the event of any such infringement, or arising from or connected with or related to the use of such devices.
- Upon the sale of any such devices, other than for buyer's right to use such devices itself, resell or
  otherwise dispose of the same, no express or implied right or license to practice or commercially
  exploit any intellectual property rights or other proprietary rights owned or controlled by
- ROHM CO., LTD. is granted to any such buyer.
- Products listed in this document are no antiradiation design.

The products listed in this document are designed to be used with ordinary electronic equipment or devices (such as audio visual equipment, office-automation equipment, communications devices, electrical appliances and electronic toys).

Should you intend to use these products with equipment or devices which require an extremely high level of reliability and the malfunction of with would directly endanger human life (such as medical instruments, transportation equipment, aerospace machinery, nuclear-reactor controllers, fuel controllers and other safety devices), please be sure to consult with our sales representative in advance.

## About Export Control Order in Japan

Products described herein are the objects of controlled goods in Annex 1 (Item 16) of Export Trade Control Order in Japan.

In case of export from Japan, please confirm if it applies to "objective" criteria or an "informed" (by MITI clause) on the basis of "catch all controls for Non-Proliferation of Weapons of Mass Destruction.

